Application/Control No. Applicant(s)/Patent Under Reexamination 09/866,334 EMBABI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Hiep Nguyen 2816 **U.S. PATENT DOCUMENTS Document Number** Date Country Code-Number-Kind Code Name Classification MM-YYYY US-5,563,557 10-1996 Sasaki, Tadahiro 333/81R Α US-В US-C US-D US-Ε F US-US-G US-Н US-J US-Κ US-US-L US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р

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